

**Main Product Characteristics:**

$V_{DSS}$	650V
$R_{DS(on)}$	0.9ohm(typ.)
$I_D$	7A


**TO220F**

**Marking and Pin Assignment**

**Schematic Diagram**
**Features and Benefits:**

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature


**Description:**

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

**Absolute max Rating:**

Symbol	Parameter	Max.	Units
$I_D$ @ TC = 25°C	Continuous Drain Current, $V_{GS}$ @ 10V ①	7	A
$I_D$ @ TC = 100°C	Continuous Drain Current, $V_{GS}$ @ 10V ①	4.4	
$I_{DM}$	Pulsed Drain Current ②	28	
$P_D$ @TC = 25°C	Power Dissipation ③	48	W
	Linear Derating Factor	0.38	W/°C
$V_{DS}$	Drain-Source Voltage	650	V
$V_{GS}$	Gate-to-Source Voltage	± 30	V
$E_{AS}$	Single Pulse Avalanche Energy @ L=15.7mH	331.7	mJ
$I_{AS}$	Avalanche Current @ L=15.7mH	6.5	A
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	°C

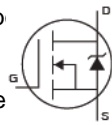
## Thermal Resistance

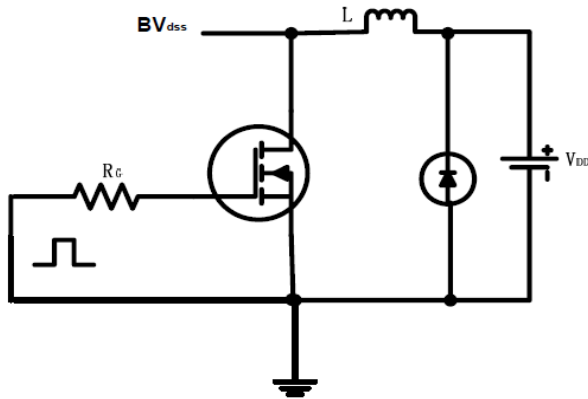
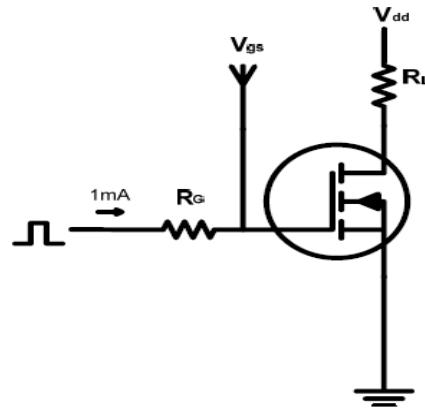
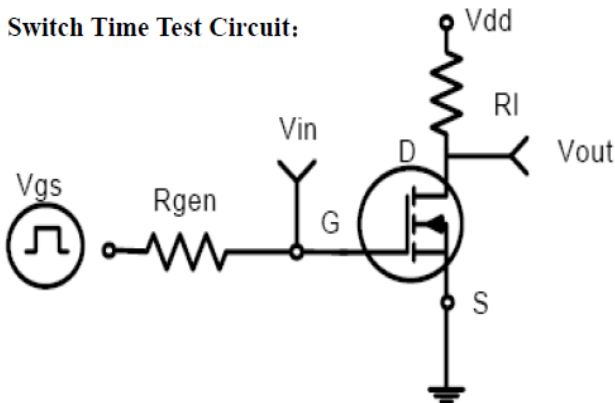
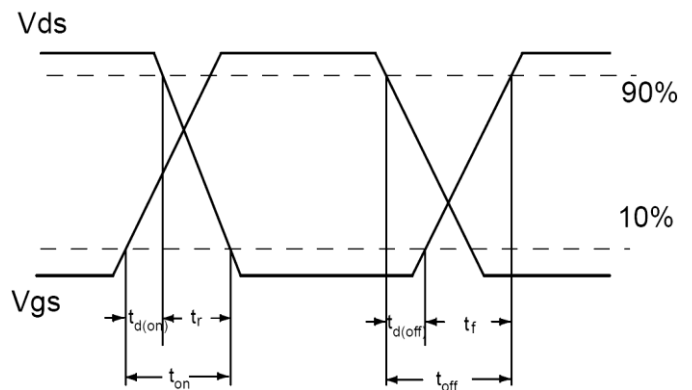
Symbol	Characterizes	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-case ③	—	2.6	°C/W
R <sub>θJA</sub>	Junction-to-ambient (t ≤ 10s) ④	—	62	°C/W
	Junction-to-Ambient (PCB mounted, steady-state) ④	—	40	°C/W

## Electrical Characterizes @T<sub>A</sub>=25°C unless otherwise specified

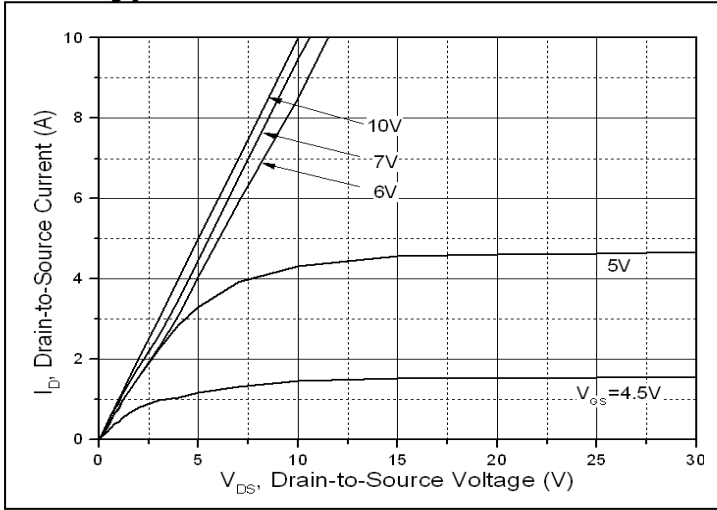
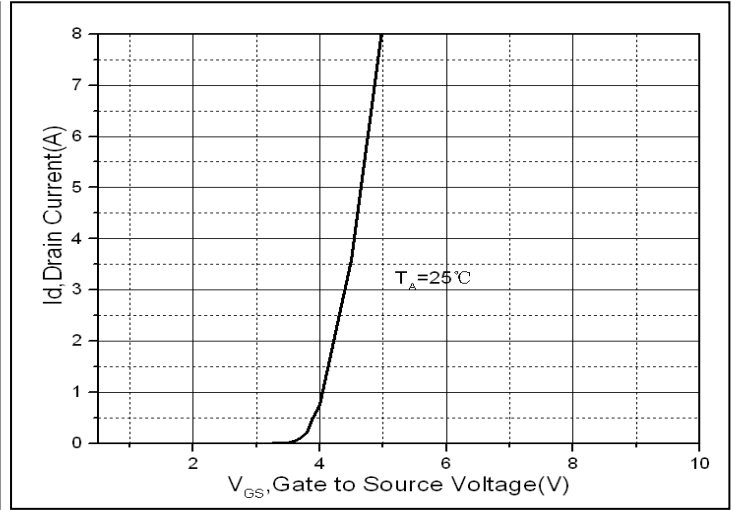
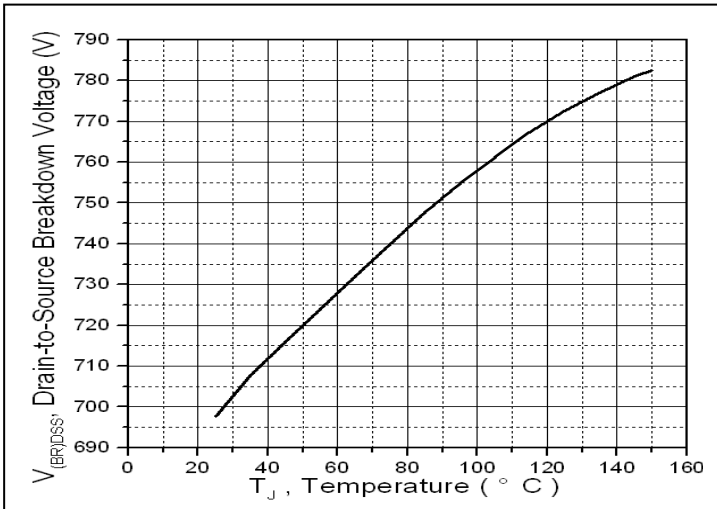
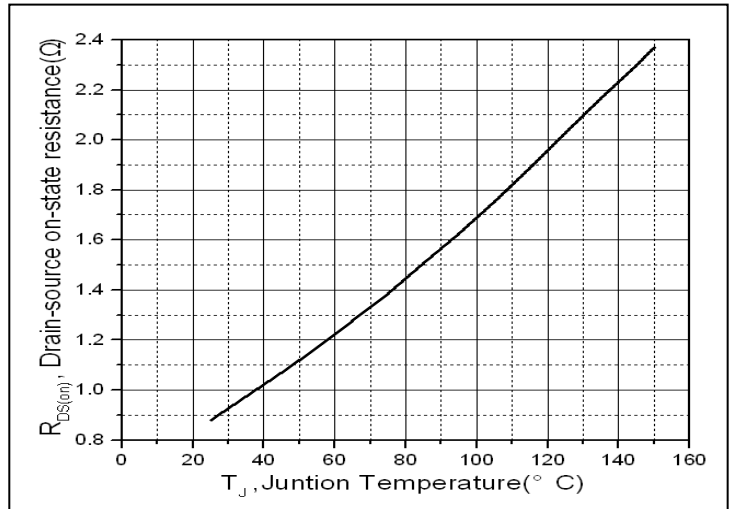
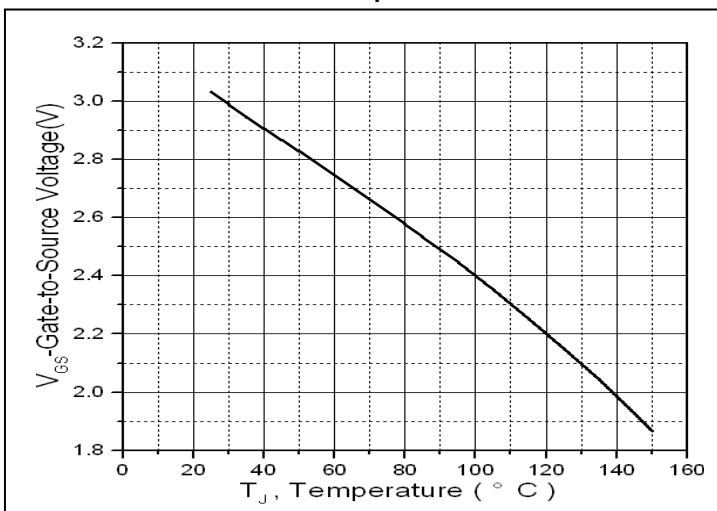
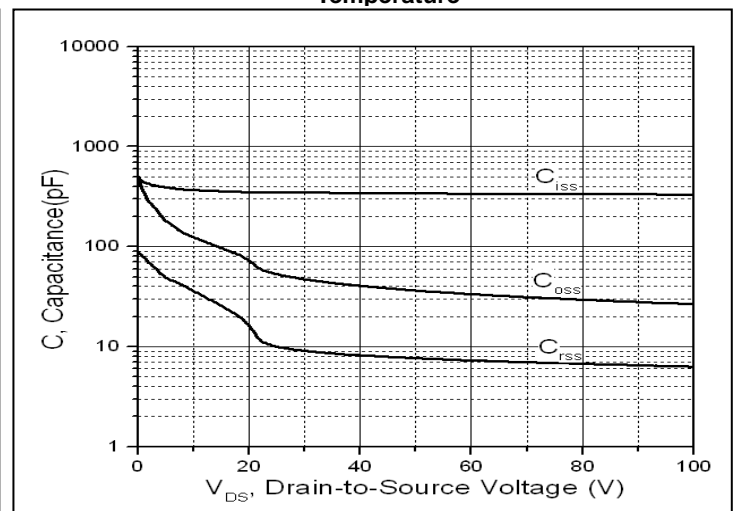
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	650	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	—	0.9	1.0	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> = 2A T <sub>J</sub> = 125°C
		—	2.03	—		
V <sub>GS(th)</sub>	Gate threshold voltage	2	—	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA T <sub>J</sub> = 125°C
		—	2.1	—		
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	1	μA	V <sub>DS</sub> = 650V, V <sub>GS</sub> = 0V T <sub>J</sub> = 125°C
		—	—	50		
I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	nA	V <sub>GS</sub> = 30V V <sub>GS</sub> = -30V
		—	—	-100		
Q <sub>g</sub>	Total gate charge	—	40.6	—	nC	I <sub>D</sub> = 7A, V <sub>DS</sub> =480V, V <sub>GS</sub> = 10V
Q <sub>gs</sub>	Gate-to-Source charge	—	5.9	—		
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	17.9	—		
t <sub>d(on)</sub>	Turn-on delay time	—	15.7	—	ns	V <sub>GS</sub> =10V, V <sub>DS</sub> =300V, R <sub>L</sub> =42.85Ω, R <sub>GEN</sub> =25Ω I <sub>D</sub> =7A
t <sub>r</sub>	Rise time	—	35.2	—		
t <sub>d(off)</sub>	Turn-Off delay time	—	136.2	—		
t <sub>f</sub>	Fall time	—	58.7	—		
C <sub>iss</sub>	Input capacitance	—	1270	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 100V f = 100kHz
C <sub>oss</sub>	Output capacitance	—	57	—		
C <sub>rss</sub>	Reverse transfer capacitance	—	9.3	—		

## Source-Drain Ratings and Characteristics

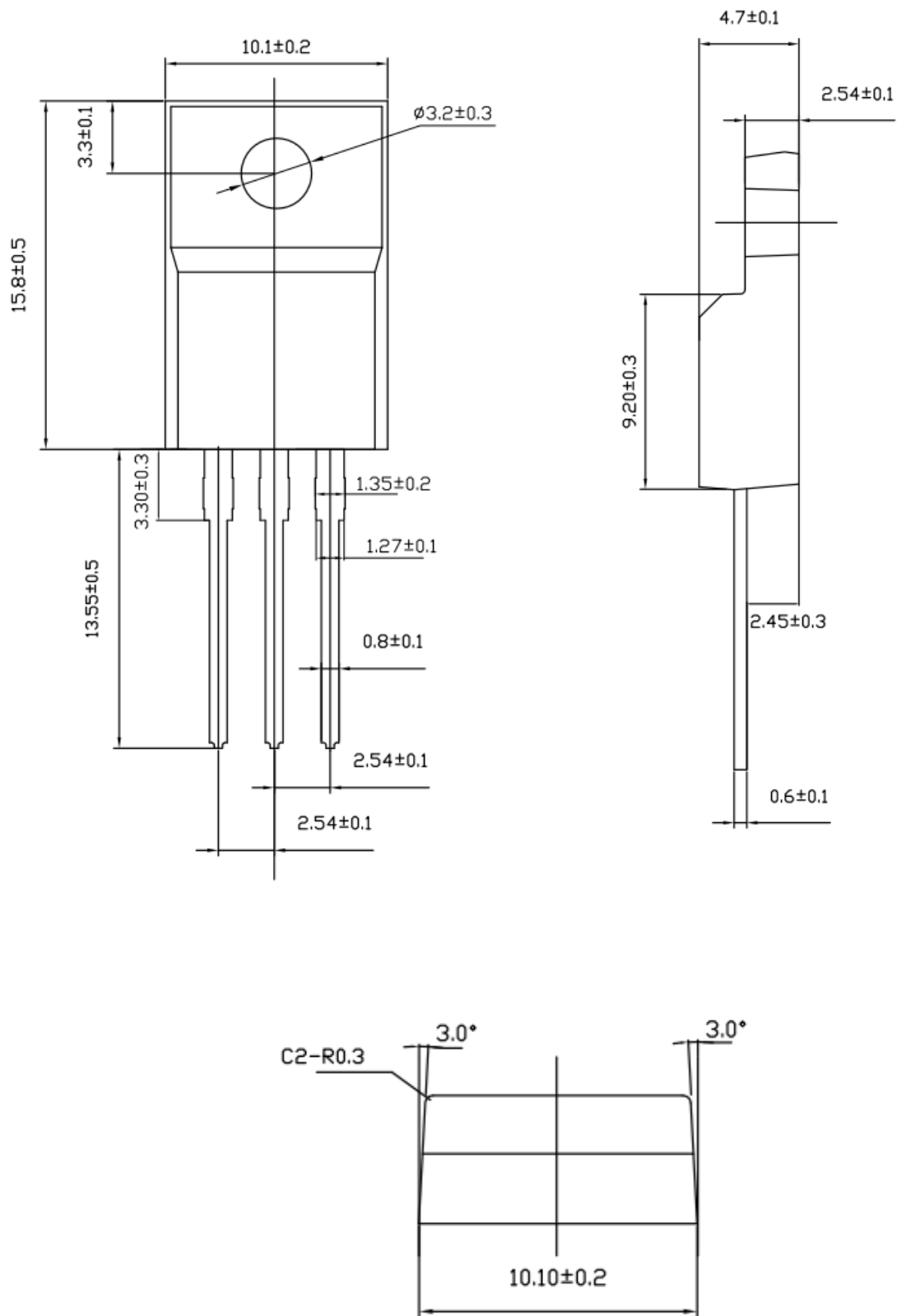
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	7	A	MOSFET symb showing the integral reverse p-n junction diode. 
I <sub>SM</sub>	Pulsed Source Current (Body Diode)	—	—	28	A	
V <sub>SD</sub>	Diode Forward Voltage	—	0.85	1.3	V	I <sub>S</sub> =7A, V <sub>GS</sub> =0V
t <sub>rr</sub>	Reverse Recovery Time	—	368.7	—	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> =7A, di/dt =
Q <sub>rr</sub>	Reverse Recovery Charge	—	3790	—	nC	100A/μs

**Test circuits and Waveforms**
**EAS test circuits:**

**Gate charge test circuit:**

**Switch Time Test Circuit:**

**Switch Waveforms:**

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$

**Typical electrical and thermal characteristics**

**Figure 1: Typical Output Characteristics**

**Figure 2: Transfer Curve**

**Figure 3: Drain-to-Source Breakdown Voltage vs. Temperature**

**Figure 4: Normalized On-Resistance Vs. Case Temperature**

**Figure 5: Gate to source cut-off voltage**

**Figure 6: Typical Capacitance Vs. Drain-to-Source Voltage**

Mechanical Data:



**Ordering and Marking Information**
**Device Marking: SSF7N65BF**

**Package (Available)**  
**TO220F**  
**Operating Temperature Range**  
**C : -55 to 150 °C**

**Devices per Unit**

Package Type	Units/Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
TO220F	50	20	1000	6	6000

**Reliability Test Program**

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	$T_j=125^{\circ}\text{C}$ to $150^{\circ}\text{C}$ @ 80% of Max $V_{DSS}/V_{CES}/VR$	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	$T_j=150^{\circ}\text{C}$ @ 100% of Max $V_{GSS}$	168 hours 500 hours 1000 hours	3 lots x 77 devices

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